

QUERY CONTROL FORM		RTIS USE ONLY	
Application No. <u>09 881,620</u>	Prepared by <u>KW</u>	Tracking Number <u>05888597</u>	
Examiner-GAU <u>Bruce 2882</u>	Date <u>2/3/2004</u>	Week Date <u>1/12/2004</u>	
	No. of queries <u>1</u>	IFW	

JACKET			
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. <u>PTO-1449</u>
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION	MESSAGE
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## FOREIGN PATENT DOCUMENTS

FA WO 0130122 04/2001 Atomique

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OTHER ART (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

OA HERTZ, H. M., et al., Debris-Free Soft X-ray Generation Using a Liquid Droplet Laser-Plasma target, Department of Physics, Lund Institute of Technology, Sweden, SPIE Vol. 2523, pp. 88-93

OB RYMELL, L., et al., Droplet Target for Low-Debris-Laser-Plasma Soft X-ray Generation, No. ¼ pp. 105-110, Optics Communications, November (1993)